

PTO FORM 1

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
A1222130SERIAL NO.
10517348LIST OF ART CITED BY APPLICANT
(Use several sheets if necessary)APPLICANT
Martin Gaudin, Refers toFILING DATE
April 2, 2004CLASS/P
2831

U.S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Name	Class	Section	Filing Date If Applicable
AA	6,198,011-B2	07-2003	Hemmer			
AB	6,255,816-B1	04-2001	Edwards			
AC	6,131,411	00-2000	Forced			
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AK						
AL						

FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	Section	Translation	
						Yes	No
	AM						
	AN						
	AO						
	AP						
	AQ						

OTHER REFERENCES (including Author, Title, Date, Conference, Pages, Etc.)

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Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MIZZ-2550	SERIAL NO. PRIORITY 09/198,034		
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Mikron Technology, Inc.			
				FILING DATE PRIORITY November 23, 1998			
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*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
gp	AA	5,497,017	03-1996	Gonzales			
gp	AB	5,408,114	04-1995	Kinoshita et al.			
gp	AC	5,468,670	11-1995	Ryou			
gp	AD	5,933,742	08-1999	Wu			
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		Document Number	Date	Country	Class	Subclass	Translation
							Yes No
	AR	DE 604219945 A1	08-04-1992	Germany			
	AS						
	AT						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)							
	AU						
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